

ESM 3: Table E3

Fit of the Measurement Models With Different Levels of Measurement Invariance across Pre- and Posttest Assessments

Construct	Invariance	χ^2 (<i>df</i>)	RMSEA	CFI	SRMR
Positive Affect	configural	10.75 (8)	0.06	0.99	0.04
	weak	14.76 (10)	0.07	0.98	0.06
	strong	17.31 (12)	0.06	0.98	0.07
	strict	22.19 (15)	0.07	0.97	0.08
School Satisfaction	configural	51.11 (18)	0.13	0.91	0.07
	weak	53.17 (21)	0.12	0.91	0.08
	strong	59.31 (24)	0.12	0.90	0.08
	strict	75.68 (26)	0.13	0.86	0.12
Negative Affect	configural	30.30 (19)	0.08	0.98	0.05
	weak	32.99 (22)	0.07	0.98	0.06
	strong	39.20 (25)	0.07	0.97	0.07
	strict	56.82 (29)	0.10	0.94	0.08
School Anxiety	configural	20.95 (8)	0.12	0.86	0.07
	weak	21.35 (10)	0.10	0.88	0.07
	strong	24.74 (12)	0.10	0.87	0.08
	strict	25.63 (15)	0.08	0.89	0.08

Note. Information Criteria are presented for the more restrictive model, respectively. *df* = degrees of freedom; AIC = Akaike Information Criterion; BIC = Bayesian Information Criterion.